



Dual N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^{a, e}	Q _g (Typ.)		
30	0.0205 at V _{GS} = 10 V	8	7.3		
30	0.026 at V _{GS} = 4.5 V	8	7.3		

FEATURES

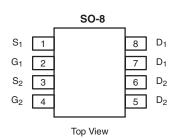
- Halogen-free
- TrenchFET® Power MOSFET
- 100 % R_g and UIS Tested



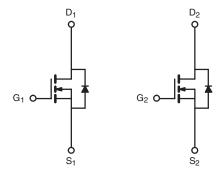
ROHS

APPLICATIONS

- Low Current DC/DC
- Notebook PC
 - System Power



Ordering Information: Si4230DY-T1-GE3 (Lead (Pb)-free and Halogen-free)



N-Channel MOSFET

N-Channel MOSFET

ABSOLUTE MAXIMUM RATIN	IGS T _A = 25 °C,	unless othe	erwise noted		
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	30	V	
Gate-Source Voltage		V_{GS}	± 20	v	
	T _C = 25 °C		8 ^e		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	1 .	7.5		
Continuous Diain Current (1) = 150 °C)	T _A = 25 °C	- I _D	7.3 ^{b, c}		
	T _A = 70 °C	1	5.8 ^{b, c}		
Pulsed Drain Current (10 μs Pulse Width)		I _{DM}	30	A	
Source-Drain Current Diode Current	T _C = 25 °C	I.	2.6		
Source-Drain Current Diode Current	T _A = 25 °C	- I _S	1.7 ^{b, c}		
Pulsed Source-Drain Current		I _{SM}	30		
Single Pulse Avalanche Current		I _{AS}	10		
Single Pulse Avalanche Energy	Pulse Avalanche Energy L = 0.1 mH		5	mJ	
Maximum Power Dissipation	T _C = 25 °C		3.2		
	T _C = 70 °C	P _D	2.1	w	
	T _A = 25 °C] 'D	2 ^{b, c}	VV	
	T _A = 70 °C	1	1.28 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	50	62.5	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	30	38] 0, W	

Notes:

- a. Based on $T_C = 25$ °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under Steady State conditions is 110 °C/W.
- e. Package limited.

Si4230DY

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A		32		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	- I _D = 250 μA		- 6			
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1.0		3.0	V	
Gate Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			100	nA	
Zana Oaka Valkana B. C. C.	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V			1	μΑ	
Zero Gate Voltage Drain Current		V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C			10		
On-State Drain Current ^b	I _{D(on)}	V _{DS} = 5 V, V _{GS} = 10 V	20			Α	
	В	V _{GS} = 10 V, I _D = 8 A		0.0172	0.0205	Ω	
Drain-Source On-State Resistance ^b	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 5 \text{ A}$		0.0205	0.026		
Forward Transconductance ^b	9 _{fs}	V _{DS} = 15 V, I _D = 8 A		29		S	
Dynamic ^a	1						
Input Capacitance	C _{iss}			950		pF	
Output Capacitance	C _{oss}	N-Channel $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		155			
Reverse Transfer Capacitance	C _{rss}	VDS = 10 V, VGS = 0 V, 1 = 1 WH12		65			
Total Cata Charga		$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 8 \text{ A}$		16.5	25	nC	
Total Gate Charge		N. Oharraal		7.3	11		
Gate-Source Charge	Q_gs	N-Channel $V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 8 \text{ A}$		2.7			
Gate-Drain Charge	Q_gd	1 D3 10 1, 1 G3 110 1, 1 D 111		2.1			
Gate Resistance	R_g	f = 1 MHz	0.2	1.2	2.4	Ω	
Turn-On Delay Time	t _{d(on)}	N. Observati		17	35	no	
Rise Time	t _r	N-Channel $V_{DD} = 15 \text{ V}, R_L = 3 \Omega$		12	24		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_q = 1 \Omega$		18	35		
Fall Time	t _f	J GLIV 9		10	20		
Turn-On Delay Time	t _{d(on)}	N. O.		9	18	ns	
Rise Time	t _r	N-Channel $V_{DD} = 15 \text{ V, R}_{L} = 3 \Omega$		11	20	-	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5 \text{ A}, V_{GEN} = 10 \text{ V}, R_q = 1 \Omega$		18	35		
Fall Time	t _f	D GEN G		8	16		
Drain-Source Body Diode Characterist	cs						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			2.6	A	
Pulse Diode Forward Current ^a	I _{SM}				30		
Body Diode Voltage	V_{SD}	I _S = 1 A		0.74	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			17	34	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	N-Channel		9	18	nC	
Reverse Recovery Fall Time	t _a	$I_F = 5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		10		ns	
Reverse Recovery Rise Time	t _b	1		7			

Notes:

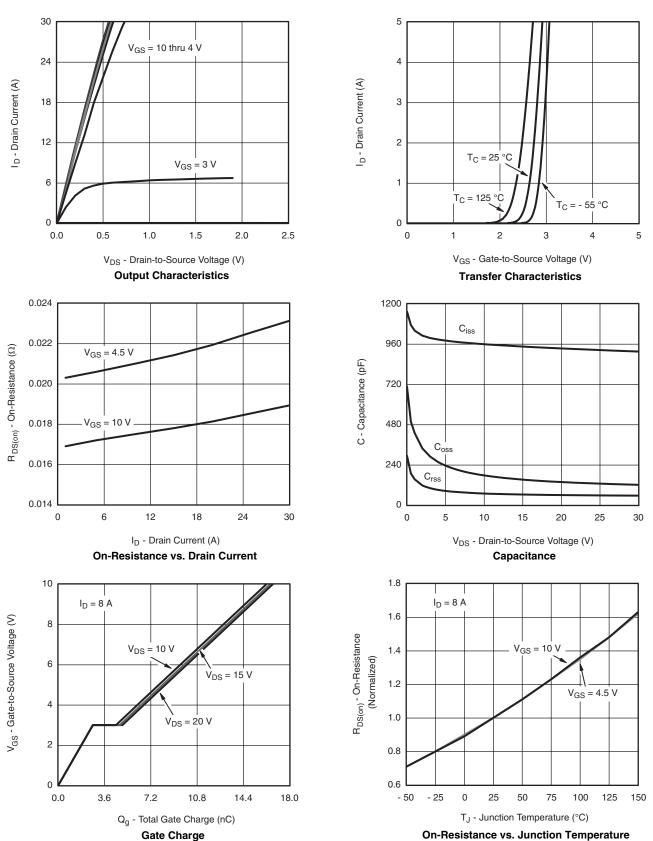
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Guaranteed by design, not subject to production testing.

b. Pulse test; pulse width $\leq 300~\mu\text{s},$ duty cycle $\leq 2~\%$



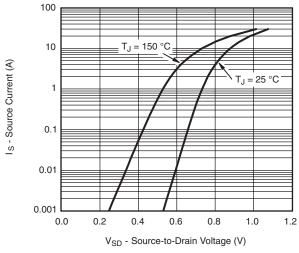
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



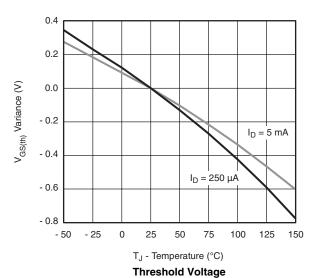
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

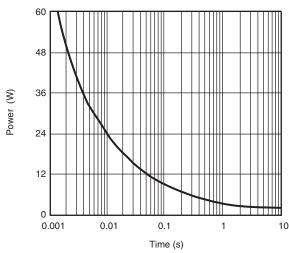


Source-Drain Diode Forward Voltage

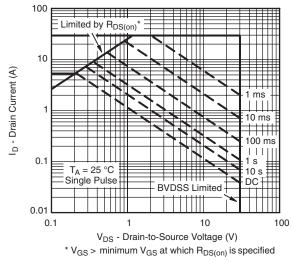


0.10 I_D = 8 A 0.08 $\mathsf{R}_{\mathsf{DS}(\mathsf{on})}$ - On-Resistance (Ω) 0.06 0.04 $T_J = 125$ °C 0.02 $T_J = 25 \, ^{\circ}C$ 0.00 0 2 3 4 5 6 8 9 10

 V_{GS} - Gate-to-Source Voltage (V) On-Resistance vs. Gate-to-Source Voltage

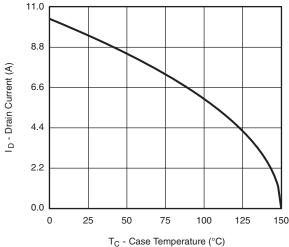


Single Pulse Power, Junction-to-Ambient

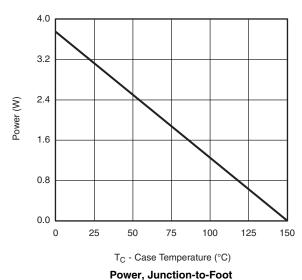


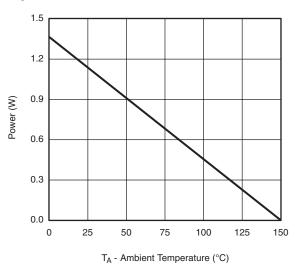


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Current Derating*





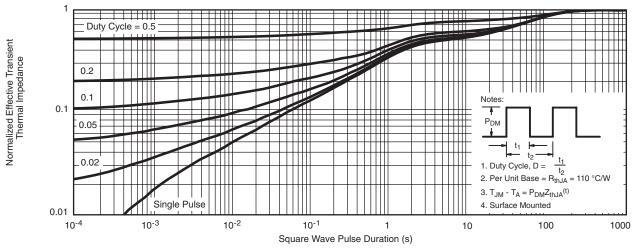
Power Derating, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

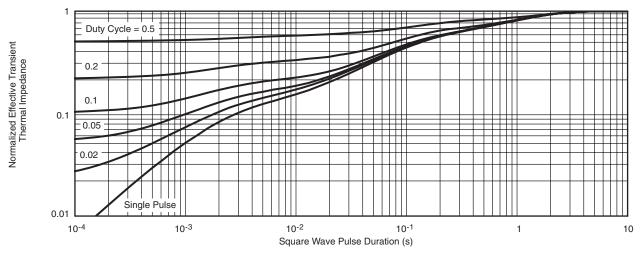
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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